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Applicant(s)/Patent under Reexamination

09/884,153

Examiner

Thomas M. Ho

ADLER ET AL.

Exammer

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	SEARCHED				
Class	Subclass	Date	Examiner		
709	225	5/9/2005	тн		
719	316	5/9/2005	тн		
719	315	5/9/2005	ТН		
717	108	5/9/2005	тн		

INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
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SEARCH (INCLUDING SEAF		")
	DATE	EXMR
EAST	5/9/2005	тн
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